Application/Control No. Applicant(s)/Patent Under Reexamination 10/656,311 CHEN ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Paul D Kim 3729 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 360/126 US-6,317,290 11-2001 Wang et al. В US-6,233,116 05-2001 Chen et al. 360/126 С US-D US-Ε US-US-F Ğ US-Н US-US-1 J US-Κ US-L US-US-FOREIGN PATENT DOCUMENTS Document Number Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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